


Search Notes 	Application/Control No. 10500562	Applicant(s)/Patent Under Reexamination KAMEI, TOSHIO
	Examiner Yeh, Eueng-nan	Art Unit 2624

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Class	Subclass	Date	Examiner

SEARCH NOTES		
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(382/173) text search - see search outputs	2007/12/31	/ey/
EAST text search - see search outputs	2007/12/27	/ey/
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EAST text search - see search history list	2009.01.22	/ey/
EAST update search - see search history output	2009/06/23	/ey/

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